Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10576806	EONNET, YVES
Examiner	Art Unit

MARCOS BATISTA

2617

SEARCHED

Class	Subclass	Date	Examiner
455	411	3/4/2008	mb
726	27	2/4/2008	mb
713	170	10/21/2008	mb
713	155	10/21/2008	mb
379	93.04		

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Steve D'Agosta	3/4/2008	mb
Consulted with TA - Yogesh Aggarwal	3/4/2008	mb
Consulted with Lun-YI Lao	3/4/2008	mb
East Search	10/21/2008	mb
Inventor's Name Seach	10/21/2008	mb
Rafael Perez Gutierrez	10/21/2008	mb
Revak, Christopher	10/16/2008	mb
Smithers, Matthew	10/17/2008	mb
Escalante, Ovidio	10/16/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
713	169	10/30/2008	mb
725	4	10/30/2008	mb

See attached search history	